


<b>Search Notes</b>  	<b>Application/Control No.</b>  10689721	<b>Applicant(s)/Patent Under Reexamination</b>  BAN ET AL.
	<b>Examiner</b>  ALEX LIEW	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
382/106,154 limited to text search	2/2/09	AL
inventors name search	2/2/09	AL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
interference search		2/2/09	AL

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